

STM beyond vacuum tunnelling: Scanning Tunnelling Hydrogen Microscopy as a route to ultra-high resolution

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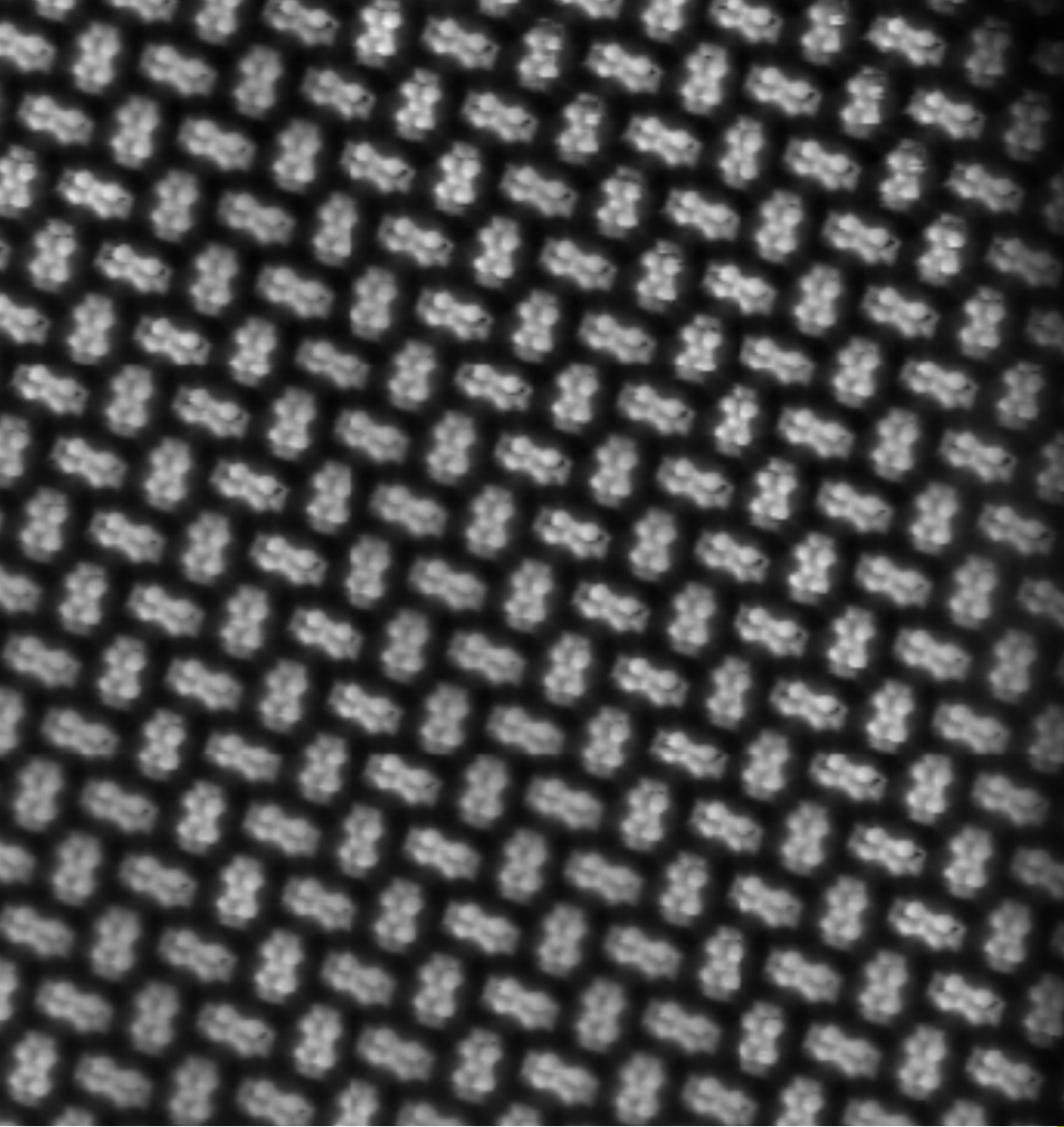
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Schlüsseltechnologien / Key Technologies
Band / Volume 47
ISBN 978-3-89336-813-6

